Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/612,346	MAUNEY ET AL.	
Examiner	Art Unit	
Tuan A. Tran	2682	

SEARCHED					
Class	Subclass	Date	Examiner		
455	41.1-2	3/31/2006	ТТ		
455	550.1				
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	DATE	EXMR
EAST (USPAT, USPGPUB, USOCR, JPO, EPO, DERWENT)	3/31/2006	π